SX9500

Ultra Low Power, Capacitive Four (4) - Channel Proximity/Button

WIRELESS & SENSING **DATASHEET**

GENERAL DESCRIPTION

The SX9500 is a low-cost, very low power 4-channel capacitive controller that can operate either as a proximity or button sensor. The SX9500 includes sophisticated on-chip auto-calibration circuitry to regularly perform sensitivity adjustments, maintaining peak performance over a wide variation of temperature, humidity and noise environments, providing simplified product development and enhanced performance.

A dedicated transmit enable (TXEN) pin is available to synchronize capacitive measurements for applications that require synchronous detection, enabling very low supply current and high noise immunity by only measuring proximity when requested.

The SX9500 operates directly from an input supply voltage of 2.7 to 5.5V, and includes a separate I2C serial bus supply input to enable communication with 1.8 – 5.5V hosts. The I2C serial communication bus reports proximity or touch detection and is used to facilitate parameter settings adjustment. Upon a proximity detection, the NIRQ output asserts, enabling the user to either determine the relative proximity distance, or simply obtain an indication of detection. The serial bus can also serve to overwrite detection thresholds and operational settings in the event the user wants to change them from their factory presets.

KEY PRODUCT FEATURES

- **2.7 – 5.5V Input Supply Voltage**
- **Capacitive Sensor Inputs**
  - 4 fF Capacitance Resolution
  - Stable Proximity & Touch Sensing With Temperature
  - Capacitance Offset Compensation to 30pF
- **Active Sensor Guarding**
- **Automatic Calibration**
- **Ultra Low Power Consumption:**
  - Active Mode: 170 uA
  - Doze Mode: 18 uA
  - Sleep Mode: 2.5 uA
- **400KHz I2C Serial Interface**
  - Four programmable I2C Sub-Addresses
  - Input Levels Compatible with 1.8V Host Processors
- **Open Drain NIRQ Interrupt pin**
- **Three (3) Reset Sources: POR, NRST pin, Soft Reset**
- **-40°C to +85°C Operation**
- **Compact Size: 3 x 3mm Thin QFN package**
- **Pb & Halogen Free, RoHS/WEEE compliant**

APPLICATIONS

- Notebooks
- Tablets
- Mobile Appliances

ORDERING INFORMATION

Semtech P/N	Package	Marking
SX9500IULTRT Note1	QFN-20	ZND8
SX9500EVK	Eval. Kit	
Note 1: Quantities are ordered in 3K units per Reel		

TYPICAL APPLICATION CIRCUIT

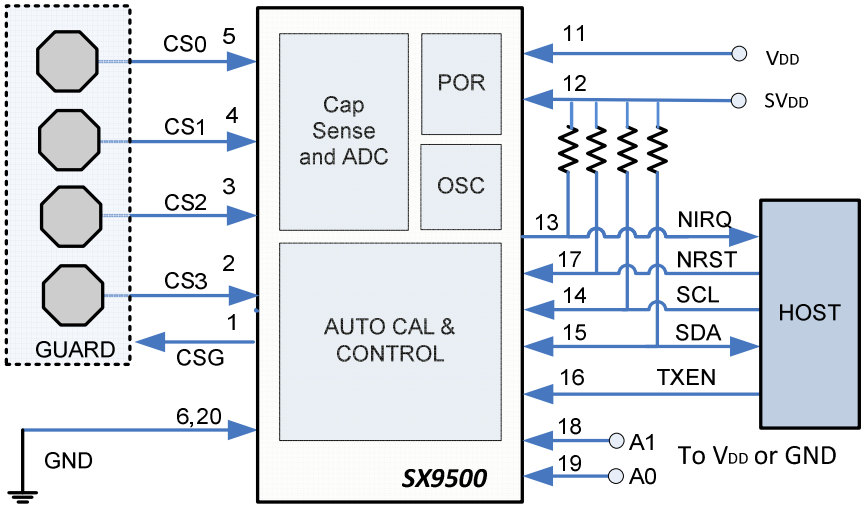

Figure 1: Typical Application Circuit

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1 GENERAL DESCRIPTION

1.1 Pin Diagram

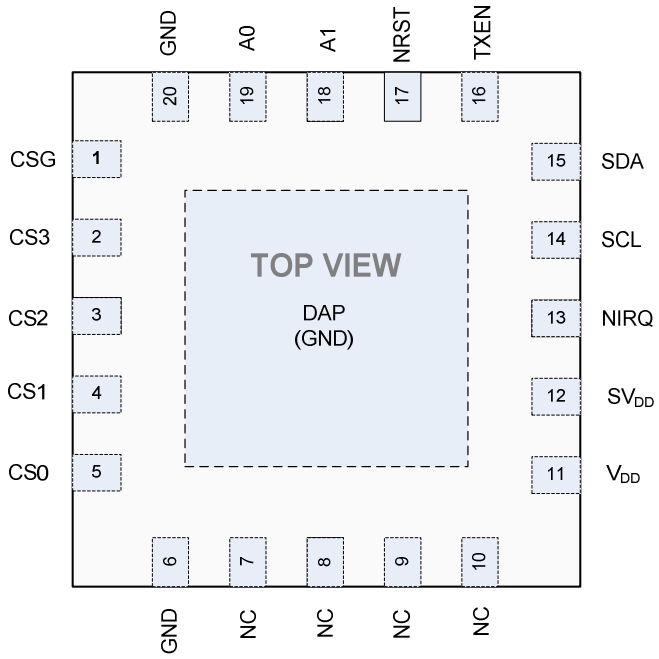
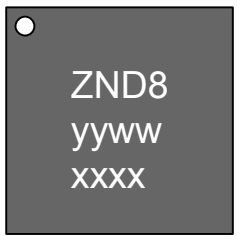


Figure 2: Pin Diagram

1.2 Marking information



yyww= Date Code
xxxx = Lot Number

Figure 3: QFN Marking Information

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1.3 Pin Identification

Pin Number	Name	Type	Description
1	CSG	Analog	Capacitive Sensor Guard
2	CS3	Analog	Capacitive Sensor, 3
3	CS2	Analog	Capacitive Sensor, 2
4	CS1	Analog	Capacitive Sensor, 1
5	CS0	Analog	Capacitive Sensor, 0
6	GND	Ground	Ground
7	NC	Not Used	Do Not Connect
8	NC	Not Used	Do Not Connect
9	NC	Not Used	Do Not Connect
10	NC	Not Used	Do Not Connect
11	V_{DD}	Power	SX9500 Core Power
12	SV_{DD}	Power	Host serial port supply voltage. Must be less than or equal to V_{DD}. NOTE: During power-up or power-down, SV_{DD} must be less than or equal to V_{DD}
13	NIRQ	Digital Output	Interrupt request, active LOW, requires pull-up resistor to SV_{DD}
14	SCL	Digital Input	I2C Clock, requires pull up resistor to SV_{DD}
15	SDA	Digital I/O	I2C Data, requires pull up resistor to SV_{DD}
16	TXEN	Input	Transmit Enable, active HIGH (Tie to SV_{DD} if not used).
17	NRST	Input	External reset, active LOW, requires pull up resistor to SV_{DD}
18	A1	Digital Input	I2C Sub-Address, connect to GND or V_{DD}
19	A0	Digital Input	I2C Sub-Address, connect to GND or V_{DD}
20	GND	Ground	Ground
DAP	GND	Ground	Exposed Pad. Connect to Ground

Table 1: Pin Description

1.4 Acronyms

DAP Die Attach Paddle

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2 ELECTRICAL CHARACTERISTICS

2.1 Absolute Maximum Ratings

Stresses above the values listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these, or any other conditions beyond the "Recommended Operating Conditions", is not implied. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability and proper functionality.

Parameter	Symbol	MIN	MAX	UNIT
Supply Voltage	V_{DD}	-0.5	6.0	V
	SV_{DD}	-0.5	6.0	
Input voltage (non-supply pins)	V_{IN}	-0.5	V_{DD}+0.3	
Input current (non-supply pins)	I_{IN}	-10	10	mA
Operating Junction Temperature	T_{JCT}	-40	125	°C
Reflow temperature	T_{RE}		260	
Storage temperature	T_{STOR}	-50	150	
ESD HBM (Human Body model, to JESD22-A114)	ESD_{HBM}	8		kV

Table 2: Absolute Maximum Ratings

2.2 Recommended Operating Conditions

Parameter	Symbol	MIN	MAX	UNIT
Supply Voltage	V_{DD}	2.7	5.5	V
	SV_{DD}	1.65	V_{DD}	
Ambient Temperature Range	T_A	-40	85	°C

Table 3: Recommended Operating Conditions

NOTE: During power-up or power-down, SV_{DD} must be less than or equal to V_{DD}

2.3 Thermal Characteristics

Parameter	Symbol	MIN	Typical	MAX	UNIT
Thermal Resistance – Junction to Air (Static Airflow)	θ_{JA}		34		°C/W

Table 4: Thermal Characteristics

NOTE: Theta JA is calculated from a package in still air, mounted to 3" x 4.5", 4 layer FR4 PCB with thermal vias under exposed pad per JESD51 standards.

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Electrical Specifications

All values are valid within the operating conditions unless otherwise specified.

Parameter	Symbol	Conditions	MIN	TYP	MAX	UNIT
Current consumption						
Sleep Mode	I_{SLEEP}	Power down, all analog circuits shut down. (I2C listening)		2.5		uA
Doze	I_{DOZE}	CPS_PERIOD = 200mS DozePeriod = 2xCps_Period CPS_FS = 167KHz CPS_RES = Medium		18		
Active	I_{ACTIVE}	CPS_PERIOD = 30mS CPS_FS = 167KHz CPS_RES = Medium		170		
Outputs: SDA, NIRQ						
Output Current at Output Low Voltage	I_{OL}	VOL = 0.4V	6			mA
Maximum Output LOW Voltage	V_{OL}(Max)	SV_{DD} > 2V			0.4	V
		SV_{DD} ≤ 2V			0.2 x SV_{DD}	
Inputs: SCL, SDA, TXEN						
Input logic high	V_{IH}		0.8 x SV_{DD}		SV_{DD} + 0.3	V
Input logic low	V_{IL}		-0.3		0.25 x SV_{DD}	
Input leakage current	I_L	CMOS input	-1		1	uA
Hysteresis	V_{HYS}	SV_{DD}> 2V		0.05x SV_{DD}		V
		SV_{DD}≤ 2V		0.1x SV_{DD}		
TXEN measurements	$TXEN_{ACTDLY}$	Delay to when the SX9500 actually begins measure-ments from when TXEN becomes active		100		µs
Inputs: A0, A1						
Input logic high	V_{IH}		0.7 x V_{DD}		V_{DD} + 0.3	V
Input logic low	V_{IL}		-0.3		0.3 x V_{DD}	

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Input: NRST						
Input logic high	V_{IH}	SV_{DD}> 2V	0.7 x SVDD		SV_{DD} + 0.3	V
		SV_{DD} ≤ 2V	0.75 x SVDD			
Input logic low	V_{IL}	SV_{DD}> 2V			0.6	
		SV_{DD} ≤ 2V			0.3 x SV_{DD}	
Start-up						
Power-up time	T_{POR}			1		ms
NRST						
NRST minimum pulse width	$T_{RESETPW}$			20		ns

Table 5: Electrical Characteristics

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Parameter	Symbol	Conditions	MIN	TYP	MAX	UNIT
I2C Timing Specifications						
SCL clock frequency	f_{SCL}				400	kHz
SCL low period	t_{LOW}		1.3			us
SCL high period	t_{HIGH}		0.6			
Data setup time	$t_{SU;DAT}$		100			
Data hold time	$t_{HD;DAT}$		0			
Repeated start setup time	$t_{SU;STA}$		0.6			
Start condition hold time	$t_{HD;STA}$		0.6			
Stop condition setup time	$t_{SU;STO}$		0.6			
Bus free time between stop and start	t_{BUF}		1.3			
Input glitch suppression	t_{SP}	Note (1)			50	ns

Note (1) -- Minimum glitch amplitude is $0.7V_{DD}$ at High level and Maximum $0.3V_{DD}$ at Low level.

Table 6: I2C Timing Specification

Note: All timing specifications, refer to Figure 4, Figure 5, and Table 6

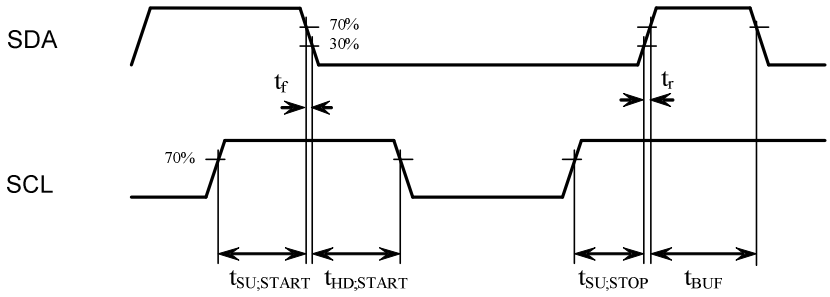

Figure 4: I2C Start and Stop timing

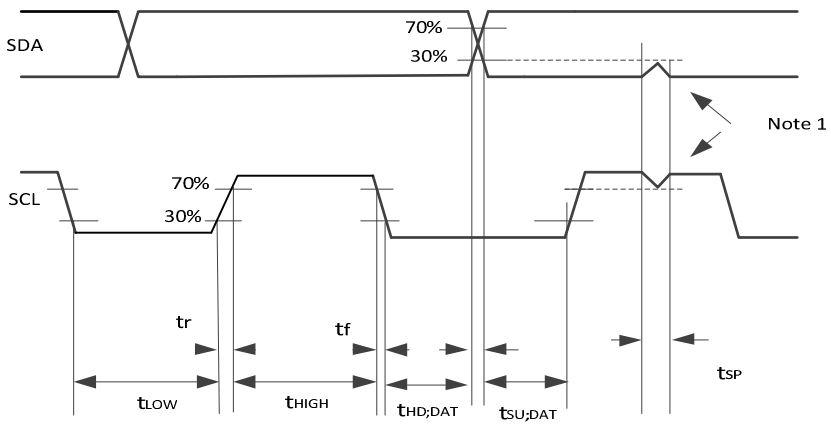

Figure 5: I2C Data timing

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3 FUNCTIONAL DESCRIPTION

3.1 Introduction

3.1.1 General

The SX9500 is a low-cost, very low-power 4-channel capacitive controller that can operate either as a proximity or button sensor. The SX9500 includes sophisticated on-chip auto-calibration circuitry to regularly perform sensitivity adjustments, maintaining peak performance over a wide variation of temperature, humidity and noise environments, providing simplified product development and enhanced performance.

3.1.2 Parameters and Configuration

The SX9500 allows the user full parameter customization for Sensor sensitivity, hysteresis, and detection thresholds. If custom parameters are used by the customer, these parameters must be uploaded by the host immediately following boot-up or after a reset.

3.1.3 Sensor Touch/Proximity Adjustment

Capacitive touch/proximity detection is directly proportional to the SX9500 internal gain and threshold settings, and external sensor area to optimize proximity detection distance. A longer touch/proximity detection range can be accomplished without changing the capacitive sensor size, by using a high sensitivity setting and/or lower signal threshold setting for touch/proximity detection.

3.2 Scan Period

The Scan period determines the minimum touch/proximity detection reaction time of the SX9500 and can be varied by the host from 30ms to approximately 400ms. Touch/proximity detection reaction time is proportional to the Scan period and inversely proportional to power consumption, so longer Scan periods corresponds to lower power, but also to longer detection reaction times.

The Scan period of the SX9500 is defined by two periods: Sensing and Idle. During the Sensing period, all enabled CS inputs, from CS0 to CS3 are sampled and any detection reported via the I2C bus (via I2C register polling or NIRQ). The Sensing period is variable and is proportional to the Scan Frequency and Resolution settings in the Cap Sensing Control Registers. During the Idle period, the SX9500 the analog circuits are placed in standby and the idle timer is initiated. Upon expiry of the idle timer, a new Scan period cycle begins.

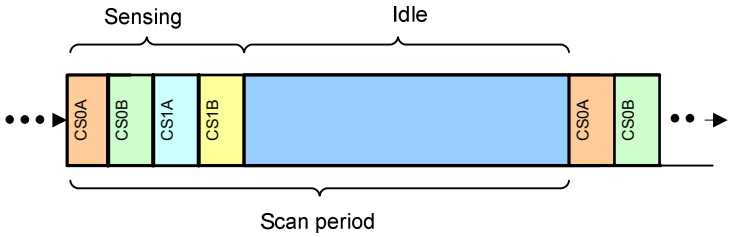

Figure 6 Scan Period

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3.3 Operational Modes

The SX9500 has four (4) operational modes: Active, Doze, Sleep, and Commanded. These modes enable tradeoffs between touch/proximity detection reaction time and power consumption.

Active: Active mode has the shortest scan periods, with a typical detection reaction time of 30ms. In this mode, all enabled sensors are scanned and information data is processed within this interval. The Active scan period is user configurable and can be extended to a maximum period of 400ms. See CPS_PERIOD register in Section 6.3, (I2C Register Overview) below.

Doze: Doze mode is by default, enabled in the SX9500. The Doze mode period is user configurable (see Section 6.3, I2C Register Overview) and can be used to extend the scan period out to 6.4 seconds for very low power consumption applications at the expense of very long detection reaction times (6.4 seconds).

In some applications, the detection reaction time needs to be fast, but can be slow when detection has not been active for a while. When the SX9500 has not detected an object for a specific time, it will automatically change modes from Active to Doze reducing power. This time-out period is determined by the CPS_DOZEPERIOD which can be configured by the user or turned OFF (CPS_DOZEEN) if not required.

Proximity detection on any sensor will cause the SX9500 to leave Doze mode and re-enter Active mode.

Sleep: Sleep mode places the SX9500 in its lowest power mode, disabling all sensor scanning and setting the idle period to continuous. In this mode, only the I2C serial bus is active.

Commanded: The commanded mode uses the TXEN input. The TXEN input enables the measurement of the capacitive channels when HIGH, likewise when the TXEN input is LOW, the SX9500 is in the Sleep mode. Specifically, on the rising edge of TXEN the SX9500 will begin measuring the capacitive channels beginning with the lowest enabled channel repeating the measurement cycle at programmed rates so long as TXEN remains HIGH. When TXEN goes LOW the current measurement sequence will complete and then measurement will cease until the next rising edge of TXEN.I2C interface

The I2C serial interface is configured as a slave device, operates at speeds up to 400 kHz and serves as the sole Host interface to the SX9500.

The SX9500 has two I/O pins (A0 and A1) that provides for four possible, user selectable I2C addresses:

A1	A0	Address
0	0	0x28
0	1	0x29
1	0	0x2A
1	1	0x2B

Table 7: I2C Sub-Address Selection

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3.4 Configuration

If the application requires customization, the SX9500 configuration registers can be changed over the I2C bus. Some I2C addressable registers are used to read sensor status and information, while other (configuration) registers allow the host to take control of the SX9500. Via the configuration registers, the host can command an operational mode change or modify the active sensors. These user programmable configuration registers are volatile, therefore during a power-down or reset event, they lose all user programmed content, requiring the host to re-write the I2C registers after the event.

3.5 Reset

A Reset to the SX9500 is performed by any one of the following methods:

- Power-up
- NRST pin
- Software reset

3.5.1 Power-up

During a power-up condition, the NIRQ output is HIGH until V_{DD} has met the minimum input voltage requirements and a T_{POR} time has expired upon which, NIRQ asserts to a LOW condition indicating the SX9500 is initialized. The Host is required to perform an I2C read to clear this NIRQ status. The SX9500 is then ready for normal I2C communication and is operational.

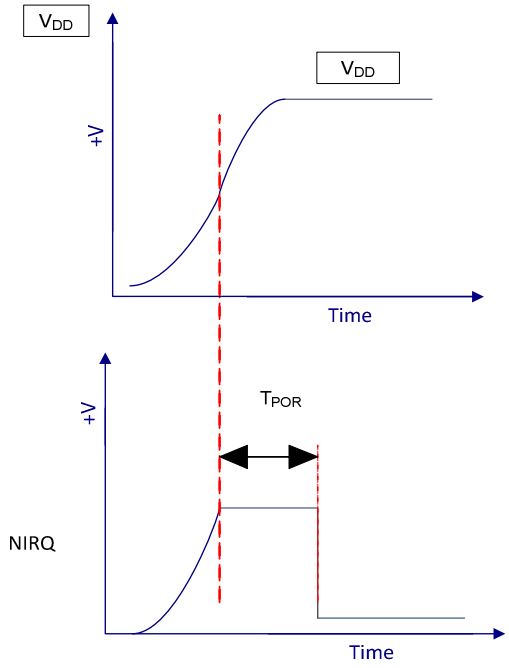

Figure 7: Power-up vs. NIRQ

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3.5.2 NRST

When NRST is asserted LOW and then HIGH, the SX9500 will reset its internal registers and will become active after period, T_{POR}. If a hardware reset control output is not available to drive NRST, then this pin must be pulled high to SV_{DD}.

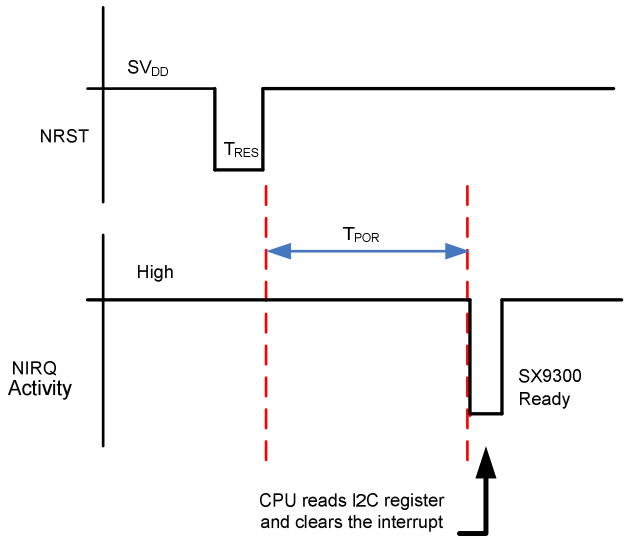

Figure 8: Hardware Reset

3.5.3 Software Reset

The host can perform software resets by writing to the I2CSoftReset register (see Section 6.3 for additional information). The NIRQ output will be asserted LOW and the Host is required to perform an I2C read to clear this NIRQ status.

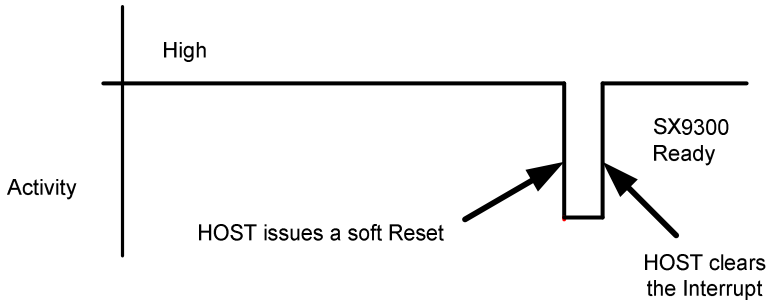

Figure 9: Software Reset

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3.6 Interrupt

Interrupt sources are disabled by default upon power-up and resets, and thus must be enabled by the host (apart from RESET IRQ). Any or all of the following interrupts can be enabled by writing a "1" into the appropriate locations within the IRQEnable register (see Section 6.3 for details):

- Touch or Proximity detected
- Completed Compensation
- Completed Conversion

The interrupt status can be read from register IRQStat for each of these interrupt sources (see Section 6.3 for details).

3.6.1 Power-up

During initial power-up, the NIRQ output is HIGH. Once the SX9500 internal power-up sequence has completed, NIRQ is asserted LOW, signaling that the SX9500 is ready. The host must perform a read to IRQSTAT to acknowledge that the status is read and the SX9500 will clear the interrupt and release the NIRQ line.

3.6.2 NIRQ Clearing

The NIRQ can be asserted in either the Active or Doze mode during a scan period. The NIRQ will be cleared when the Host performs a read of the RegIrqStat I2C register.

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4 PIN DESCRIPTIONS

4.1 Introduction

This section describes the SX9500 pin functionality, pin protection, whether or not the pins are analog or digital, and if they require pull-up resistors. There is ESD protection on all SX9500 I/O.

4.2 V_{DD} and SV_{DD}

These are the device supply voltages. V_{DD} is the supply voltage for the internal core and I/O. SV_{DD} is the supply voltage for the I2C serial interface. NOTE: SV_{DD} MUST be equal or lower than V_{DD}.

4.3 TXEN

This signal can be used in many applications if a conversion trigger/enable is needed. This input pin synchronizes the capacitance sensing inputs. When this signal is active, SX9500 immediately performs capacitive measurements. If this input becomes inactive during the middle of a measurement, the SX9500 will complete all remaining measurements and will enter sleep mode until TXEN goes active again.

4.4 Capacitor Sensing Interface (CS0, CS1, CS2, CS3, CSG)

The Capacitance Sensor input pins CS0, CS1, CS2 and CS3 are connected directly to the Capacitor Sensing Interface circuitry which converts the sensed capacitance into digital values. The Capacitive Sensor Guard (CSG) output provides a guard reference to minimize the parasitic sensor pin capacitances to ground. Capacitance sensor pins which are not used must be left open-circuited. Additionally, CS pins must be connected directly to the capacitive sensors using a minimum length circuit trace to minimize external “noise” pick-up.

The capacitance sensor and capacitive sensor guard pins are protected from ESD events to VDD and GROUND.

4.5 Host Interface

The Host Interface consists of: NIRQ, NRST, SCL, SDA, and TXEN. These signals are discussed below.

4.5.1 NIRQ

The NIRQ pin is an open drain output that requires an external pull-up resistor (1..10 kOhm). The NIRQ pin is protected from ESD events to SVDD and GROUND.

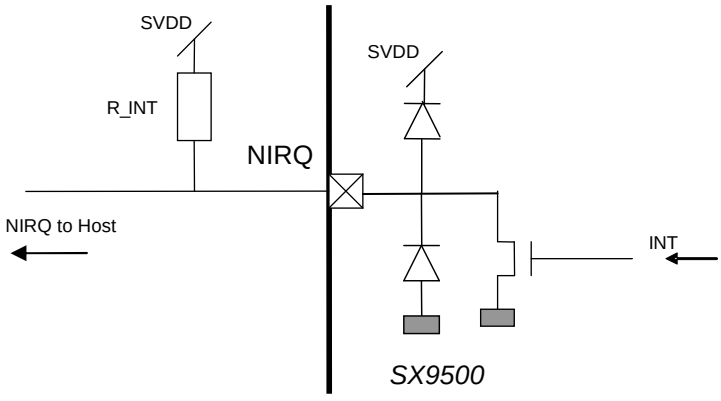

Figure 10: NIRQ Output Simplified Diagram

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4.5.2 SCL, NRST and TXEN

The SCL, NRST and TXEN pins are high impedance input pins that require an external pull-up resistor (1..10 kOhm). It is possible to connect NRST and TXEN Host output drivers directly without the requirement for a pull-up resistor if driven from a push-pull host output. These pins are protected from ESD events to SVDD and GROUND.

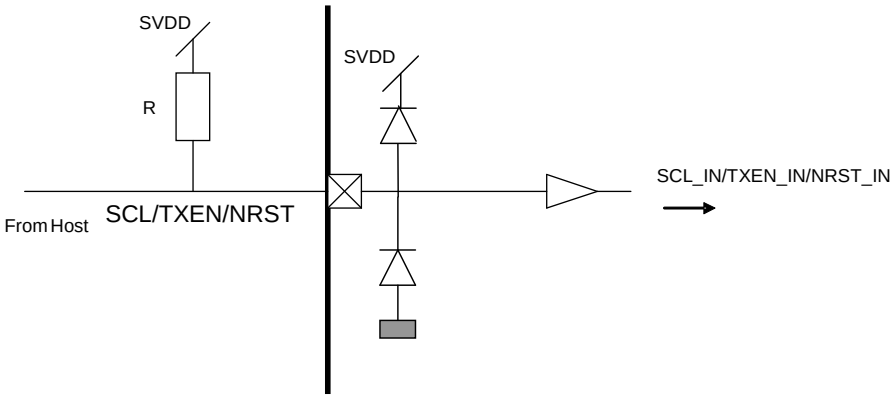

Figure 11: SCL/TXEN/NRST

4.5.3 SDA

SDA is an I/O pin that requires an external pull-up resistor (1..10 kOhm). The SDA I/O pin is protected to SV_{DD} and GROUND.

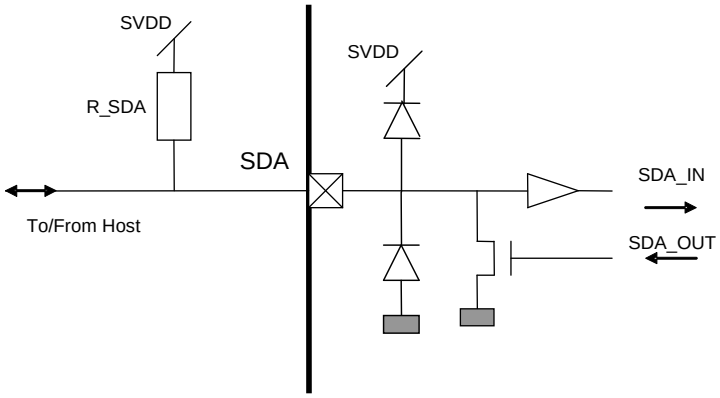

Figure 12: SDA Simplified Diagram

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5 DETAILED CONFIGURATION DESCRIPTIONS

5.1 Introduction

The SX9500 is a low-cost, very low power 4-channel capacitive controller that can operate either as a proximity or button sensor. It includes sophisticated on-chip auto-calibration circuitry to regularly perform sensitivity adjustments, maintaining peak performance over a wide variation of temperature, humidity and noise environments, providing simplified product development and enhanced performance. The SX9500 comes with factory default settings that are appropriate for most general applications, however a full complement of registers are accessible to the user to enable application customization and optimization. A dedicated transmit enable (TXEN) pin is available to synchronize capacitive measurements and reduce power dissipation for applications that require synchronous detection, enabling very low supply current and high noise immunity by only measuring proximity when requested.

5.2 Capacitive Sensor (CS0, CS1, CS2, CS3) Parameters

The SX9500 sensor has default parameters for the Capacitive Sensors that provides a quick and initial starting point to achieve touch/proximity detection. However, because of unique sensor sizes and sensor locations, it is possible to achieve higher and more robust performance with minor changes to these default parameters. In general only a few registers require changes to their default parameters to achieve improved performance. These registers are:

5.2.1 Set CPS_Digital_GAIN [6:5] (Cap Sensor Gain)

The address for the (capacitive) sensor gain is: Bits [6:5] provide for four (4) gain settings as shown below:

Bits		
6	**5**	**Gain**
0	0	x 1
0	1	x 2
1	0	x 4
1	1	x 8

Table 8: CPS_Digital_GAIN

5.2.2 Set CPS_C_{IN}R [1:0] (Input Capacitance Range and Resolution)

The register for the input capacitance full scale range and resolution is: Bits [1:0] provide set ability over the expected maximum sensed capacitance. A setting of 00 on these bits provides for the largest capacitance measurement range, but is not as sensitive for the longest proximity distance, while the setting of 11 provides for the smallest capacitive measurement range, and provides the longest proximity distance. The table for this register is shown below:

Bits		
1	**0**	**C_{INPUT} Range/Resolution**
0	0	Large
0	1	Medium-Large
1	0	Medium-Small
1	1	Small

Table 9: C_{INPUT} Range and Resolution Register

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5.2.3 Set CPS_TRS [4:0] (Detection threshold)

This register defines the detection threshold for all sensors and the details are shown below. Lower thresholds provide longer proximity detection distances but are more susceptible to noise, while higher threshold values provide immunity to noise, but results in shorter proximity detection range. The default value for this register is [00000].

BITS					
4	**3**	**2**	**1**	**0**	**THRESHOLD VALUE**
0	0	0	0	0	0
0	0	0	0	1	20
0	0	0	1	0	40
0	0	0	1	1	60
0	0	1	0	0	80
0	0	1	0	1	100
0	0	1	1	0	120
0	0	1	1	1	140
0	1	0	0	0	160
0	1	0	0	1	180
0	1	0	1	0	200
0	1	0	1	1	220
0	1	1	0	0	240
0	1	1	0	1	260
0	1	1	1	0	280
0	1	1	1	1	300
1	0	0	0	0	350
1	0	0	0	1	400
1	0	0	1	0	450
1	0	0	1	1	500
1	0	1	0	0	600
1	0	1	0	1	700
1	0	1	1	0	800
1	0	1	1	1	900
1	1	0	0	0	1000
1	1	0	0	1	1100
1	1	0	1	0	1200
1	1	0	1	1	1300
1	1	1	0	0	1400
1	1	1	0	1	1500
1	1	1	1	0	1600
1	1	1	1	1	1700

Table 10: Cap Sensor Threshold

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5.2.4 Set CPS_HYST [5:4] (Detection Hysteresis)

This register defines the detection hysteresis for all sensors. Hysteresis for the capacitive sensors provides an important function in that it keeps the SX9500 from providing "oscillating" results when detection levels are close to threshold. The register details are shown below.

Bits		
5	4	DETECTION HYSTERESIS
0	0	32
0	1	64
1	0	128
1	1	256

Table 11: CPS_HYST

5.2.5 Set CPS_AVGDEB[7:6] (Average Pos/Neg Debouncing)

Use of debounce in the SX9500 is recommended as it will reduce the effects of extraneous noise for reported detection. The SX9500 includes several conditions for debounce: Close, Far, and Data Detection.

Bits		
7	6	AVERAGE POS/NEG DEBOUNCING
0	0	OFF
0	1	2 Samples
1	0	4 Samples
1	1	8 Samples

Table 12: CPS_AVGDEB

5.2.6 Set CPS_AVGNEGFILT[5:3] & CPS_AVGPOSFILT[2:0] (Average Neg/Pos Filters)

The SX9500 includes circuitry to average out the detected signals. These detected signals can be both positive and negative, and so there are registers to control both the positive and negative averaging filter coefficients. There are eight (8) settings possible in each of these filters ranging from OFF up to Highest filtering. Use of these filters is recommended for noisy environment and represents a tradeoff detection response versus false triggering. See CPS_AVGNEGFILT and CPS_AVGPOSFILT for register and bit locations.

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5.2.7 Set CPS_FS[4:3] (Sampling Frequency)

The capacitance sampling frequency can be changed in CPS_CTRL2 if the environment is particularly noisy. Changing this frequency affects the Capacitance Sensing period. It is recommended to use the 167 kHz sampling frequency.

Bits		
4	**3**	**SAMPLING FREQUENCY**
0	0	83 kHz
0	1	125 kHz
1	0	167 kHz
1	1	Reserved, do not use

Table 13: Sampling Frequency Control

5.2.8 Set CPS_RES[2:0] (Resolution Factor)

The CPS Resolution factor has eight (8) possible settings that range from coarsest to very fine that controls the total number of measurements per sensor in a Scan Period. Along with the CPS Sampling Frequency, changing this register affects the SX9500 Sensing Period. This register is located in CPS_CTRL2.

Bits			
2	**1**	**0**	**RESOLUTION**
0	0	0	Coarsest
0	0	1	Very Coarse
0	1	0	Coarse
0	1	1	Medium Coarse
1	0	0	Medium
1	0	1	Fine
1	1	0	Very Fine
1	1	1	Finest

Table 14: CPS Resolution Factor

5.2.9 Set CPS_AVGTRS[7:0] (Averaging Threshold)

The SX9500 performs averaging on all capacitive measurements to determine when to perform a calibration cycle. The CPS_AVGTRS register is used to set an 8-bit positive and negative threshold that determines when a calibration is internally requested. Typically the user would set this register to be between 10000000 [7:0] to 11000000 [7:0] which corresponds to ½ to ¾ of the system dynamic range.

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5.3 Additional Parameter Settings

Further application customization is possible to control scan period, enabled sensors and individual sensor interrupts are also possible. Scan period affects both power dissipation and detection reaction time.

5.3.1 Set CPS_PERIOD[6:4] (Scan Period)

This register controls the scan period of the SX9500 over a range of 30ms to 400ms.

Bits			
6	**5**	**4**	**Scan PERIOD (ms)**
0	0	0	30
0	0	1	60
0	1	0	90
0	1	1	120
1	0	0	150
1	0	1	200
1	1	0	300
1	1	1	400

Table 15: Scan Period, Register 0x06

5.3.2 Set CPS_EN [3:0] (Enable Capacitive Sensor Inputs)

If any capacitive sensors are not required, they can be disabled in this register. Each bit in this register corresponds to a specific sensor input. A logic “1” enables the capacitive sensor input, while a logic “0” disables a capacitive input.

CS0 = Bit 0

CS1 = Bit 1

CS2 = Bit 2

CS3 = Bit 3

5.3.3 Set IRQ_Enable [6:3] (Enable Interrupt Sources)

There are a number of interrupt sources that the SX9500 can report. A logic “1” in the specific location will enable the specific interrupt as shown below.

TCHIRQEN [6]: Enables the Touch/Proximity Detection IRQ

RLSIRQEN [5]: Enables the Touch/Proxmity No Detect IRQ

COMPDONEIRQEN [4]: Enables the Compensation Done Notification IRQ

CONVIRQEN [3]: Enables the Conversion Completion Done Notification IRQ

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6 I2C INTERFACE

The I2C implemented on the SX9500 is compliant with:

- Standard (100kb/s) and fast mode (400kb/s)
- I2C standard slave mode
- 7 bit address (default is 0x28 assuming A1=A0=0).

The host can use the I2C to read and write data at any time, and these changes are effective immediately. Therefore the user should ideally disable the sensor before changing settings, or discard the results while changing (Section 3.2).

There are four types of I2C registers:

- Control and Status (read). These registers give information about the status of the capacitive sensors
- Operation Control (read/write). These registers control Operating Modes.
- Cap Sensor Control and Parameters (read/write)
- Cap Sensor Data Read Back (read)

The I2C can be used to read and write from a start address and then perform read or writes sequentially, and the address increments automatically.

Supported I2C access formats are described in the next sections.

6.1 I2C Write

The format of the I2C write is given in Figure 12. After the start condition [S], the slave address (SA) is sent, followed by an eighth bit ('0') indicating a Write. The SX9500 then Acknowledges [A] that it is being addressed, and the Master sends an 8 bit Data Byte consisting of the SX9500 Register Address (RA). The Slave Acknowledges [A] and the master sends the appropriate 8 bit Data Byte (WD0). Again the Slave Acknowledges [A]. In case the master needs to write more data, a succeeding 8 bit Data Byte will follow (WD1), acknowledged by the slave [A]. This sequence will be repeated until the master terminates the transfer with the Stop condition [P].

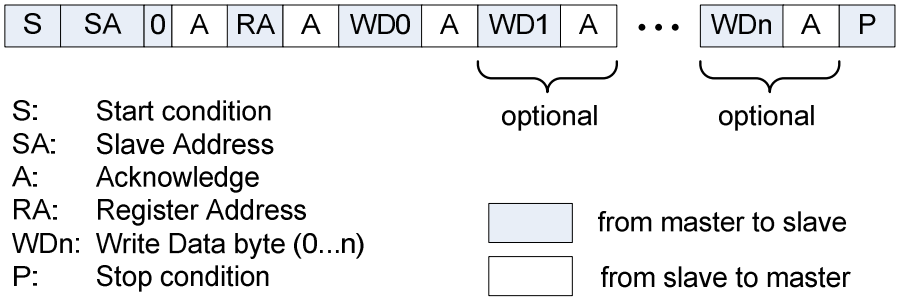

Figure 13: I2C Write

The register address is incremented automatically when successive register data (WD1...WDn) is supplied by the master.

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6.2 I2C Read

The format of the I2C read is given in Figure 13. After the start condition [S], the slave address (SA) is sent, followed by an eighth bit ('0') indicating a Write. The SX9500 then Acknowledges [A] that it is being addressed, and the Master responds with an 8-bit Data consisting of the Register Address (RA). The Slave Acknowledges [A] and the master sends the Repeated Start Condition [Sr]. Once again, the slave address (SA) is sent, followed by an eighth bit ('1') indicating a Read. The SX9500 responds with an Acknowledge [A] and the read Data byte (RD0). If the master needs to read more data it will acknowledge [A] and the SX9500 will send the next read byte (RD1). This sequence can be repeated until the master terminates with a NACK [N] followed by a stop [P].

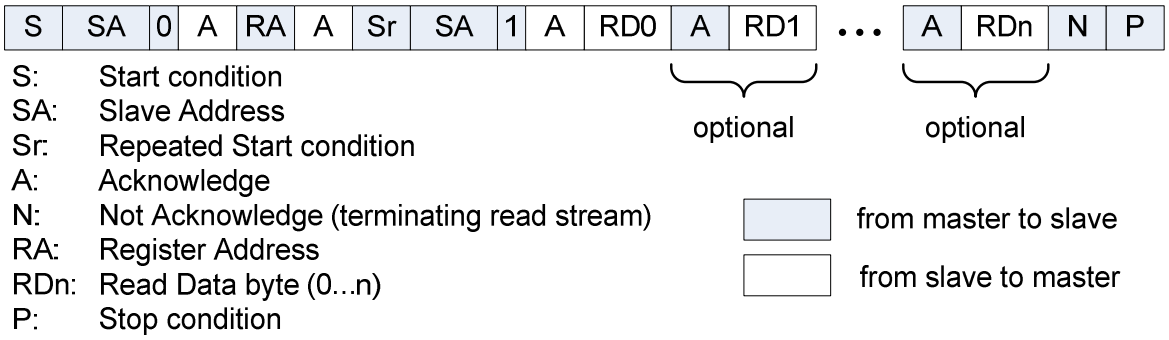

Figure 14: I2C Read

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6.3 Register Overview

Add	Reg	Acc	Bits	Field	Reset	Function
General Control & Status						
0x00	IRQStat	R	7	RESETIRQ	1	Reset event occurred
			6	TCHIRQ	0	Sensor detected a touch/proximity
			5	RLSIRQ	0	Sensor detected a release condition
		R/W	4	COMPDONE	0	Compensation complete. Writing a one in this bit trigs a compensation on all channels
		R	3	CONVIRQ	0	Conversion cycle complete
			2:1	Not Used	00	Not Used
			0	TXENSTAT	0	Reports TXEN pad status
0x01	TchCmpStat	R	7	TCHSTAT3	0	Determines if touch/proximity has been detected on CS3
			6	TCHSTAT2	0	Determines if touch/proximity has been detected on CS2
			5	TCHSTAT1	0	Determines if a touch/proximity has been detected on CS1
			4	TCHSTAT0	0	Determines if a touch/proximity has been detected on CS0
			3:0	COMPSTAT	1111	Specifies which capacitive sensor(s) has a compensation pending
General Operations Control						
0x03	IRQ_Enable	R	7	Not Used	0	Not Used
		R/W	6	TCHIRQEN	0	Enables the detection irq
			5	RLSIRQEN	0	Enables the release irq
			4	COMPDONEIRQEN	0	Enables the compensation irq
			3	CONVIRQEN	0	Enables the conversion irq
		R	2:0	Not Used	000	Not Used
Cap Sensing Control						
0x06	CPS_CTRL0	R/W	7	Not Used	0	Not Used
			6:4	CPS_PERIOD	000	Scan period : 000: 30 ms 001: 60 ms 010: 90 ms 011: 120 ms 100: 150 ms 101: 200 ms 110: 300 ms 111 : 400 ms
			3:0	CPS_EN	1111	Enables CS0 through CS3
0x07	CPS_CTRL1	R/W	7:6	CPS_SH	01	CG bias/shield usage. 00 : Off, CG high-Z (off) 01: On(def.) 10: Reserved 11: Reserved
			5:2		0000	Not used
		R/W	1:0	CPS_C_{IN}R	00	Capacitance Range & Resolution:

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						00: Large 01: Medium Large 10: Medium Small 11: Small
0x08	CPS_CTRL2	R/W	7	Not Used	0	Not Used
			6:5	CPS_Digital_GAIN	00	Set Digital gain factor 00: Gain = 1 01: Gain = 2 10: Gain = 4 11: Gain = 8
			4:3	CPS_FS	01	Sampling frequency 00: 83 kHz 01: 125 kHz 10: 167 kHz (Typical) 11: Reserved
			2:0	CPS_RES	000	Resolution Control 000: Coarsest …. …. 111: Finest
0x09	CPS_CTRL3	R/W	7	Not Used	0	Not Used
			6	CPS_DOZEEN	1	Enables doze mode
			5:4	CPS_DOZEPERIOD	00	When doze is enabled, the cap sensing period moves from CPS_PERIOD to CPS_PERIOD * : 00: 2*CPS_PERIOD 10: 8* CPS_PERIOD 01: 4*CPS_PERIOD 11: 16*CPS_PERIOD
			3:2	Reserved	00	Must be 00
			1:0	CPS_RAWFILT	00	Raw filter coefficient 00: off 01: Low 10: Medium 11: High (Max Filtering)
0x0A	CPS_CTRL4	R/W	7:0	CPS_AVGTRS	00000000	Average pos/neg threshold = 8 x reg
0x0B	CPS_CTRL5	R/W	7:6	CPS_AVGDEB	00	Average pos/neg de-bouncer: 00: off 01: 2 samples 10: 4 samples 11: 8 samples
			5:3	CPS_AVGNEGFILT	000	Average negative filter coefficient : 000: off 001: Lowest …. …. 111: Highest (Max. Filter)
			2:0	CPS_AVGPOSFILT	000	Average positive filter coefficient : 000: off 001: Lowest …. ….. 111: Highest (Max. Filter)
0x0C	CPS_CTRL6	R/W	7:5	Not Used	000	Not Used
			4:0	CPS_TRS	00000	Defines the touch/prox

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						detection threshold for all sensors. See Table 10
0x0D	CPS_CTRL7	R/W	7	CPS_CMPAUTOOFF	0	Disables the automatic compensation trigged by average
			6	CPS_CMPTRG	0	0: compensate channels independently 1: compensate all channels when triggered
			5:4	CPS_HYST	00	Detection hysteresis 00: 32 01: 64 10: 128 11: 256
			3:2	CPS_CLSDEB	00	Close debouncer 00: off 01: 2 samples 10: 4 samples 11: 8 samples
			1:0	CPS_FARDEB	00	Far debouncer 00: off 01: 2 samples 10: 4 samples 11: 8 samples
0x0E	CPS_CTRL8	R/W	7:4	CPS_STUCK	0000	Stuck at timeout timer : 0000 : off 00XX: increment every CPS_STUCK x 64 active frames 01XX: increment every CPS_STUCK x 128 active frames 1XXX: increment every CPS_STUCK x 256 active frames
			3:0	CPS_CMPPRD	0000	Periodic compensation 0: off else : increment every CPS_COMPPRD x 128 active frames
Sensor Readback						
0x20	CPSRD		7:2	Not Used	000000	Not Used
		R	1:0	CPSRD	00	Determines which sensor data will be available in the next Reg read.
0x21	UseMSB	R	7:0	SENSUSEMSB	00000000	Provides the useful information for monitoring purposes. Signed, 2's complement format
0x22	UseLSB	R	7:0	SENSUSELSB	00000000	
0x23	AvgMSB	R	7:0	SENSAVGMSB	00000000	Provides the average information for monitoring purposes. Signed, 2's complement format
0x24	AvgLSB	R	7:0	SENSAVGLSB	00000000	
0x25	DiffMSB	R	7:0	SENSDIFFMSB	00000000	Provides the differential information for monitoring purposes. Signed, 2's complement format
0x26	DiffLSB	R	7:0	SENSDIFFLSB	00000000	
0x27	OffMSB	R/W	7:0	SENSOFFMSB	00000000	Offset compensation DAC code. This is writable to allow forcing some DAC
0x28	OffLSB	R/W	7:0	SENSOFFLSB	00000000	

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						codes. When written, the internal DAC code is updated after the write of the LSB reg. MSB and LSB regs should be written in sequence.
0x7F	I2CSoftReset	W	7:0	SOFTRESET	00000000	Write 0xDE and RESET the chip

Table 16: Register Overview

6.4 Sensor Design

This section describes how to properly design capacitive sensors for touch or proximity. Sensors can be designed in a variety of shapes depending on the physical requirements of the system, but to achieve optimum performance, a careful recognition of the CSG between sensors and below must be given in the design.

An optimum capacitive sensor should have minimum parasitics to both system ground and to the CSG. System ground parasitics can be minimized with distance between the capacitive sensor and system ground, however CSG will be directly adjacent to each sensor as well as directly under it (on an adjacent PC board layer). It is easy to generate a significant capacitance this way and therefore it is recommended to cross-hatch the guard to a large extent. The recommended "fill" for the cross-hatched area is about 20% metal.

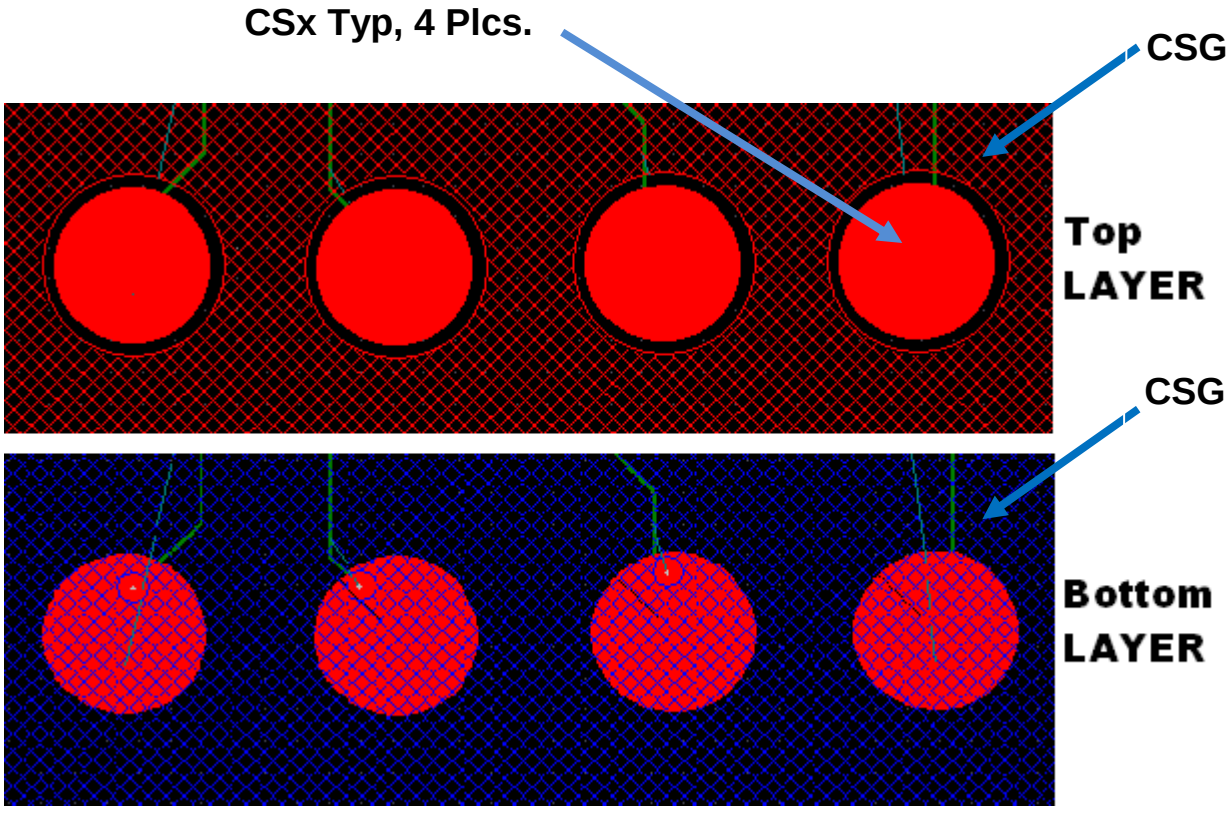

Figure 15: Typical Touch/Proximity Capacitive Sensor

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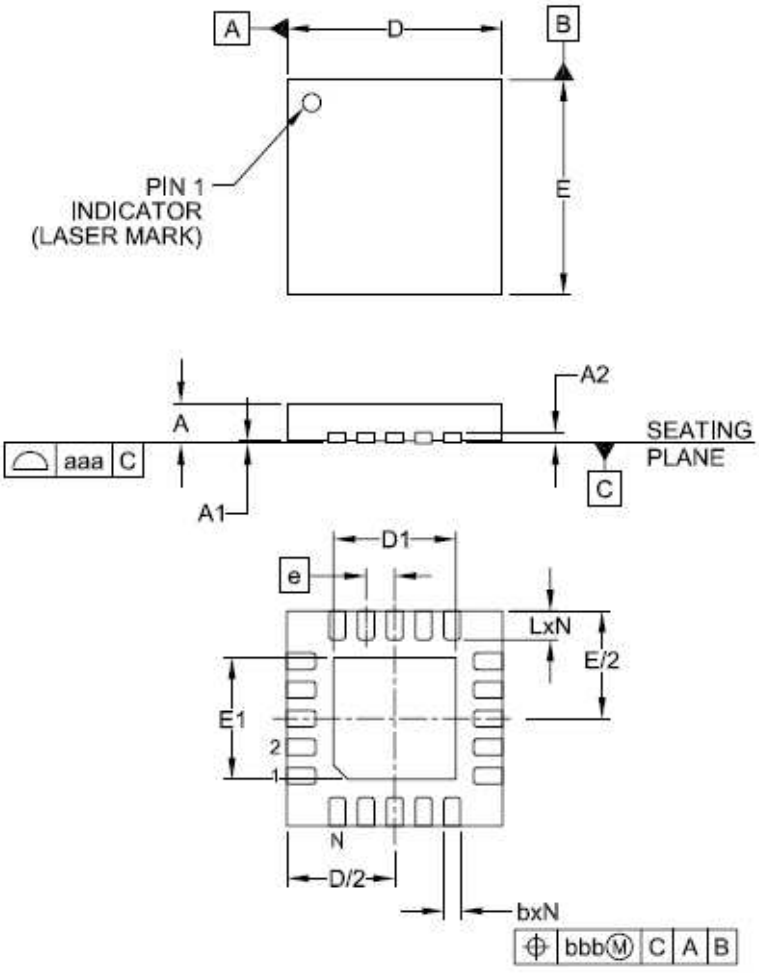
7 PACKAGING INFORMATION

7.1 Package Outline Drawing



DIMENSIONS						
DIM	INCHES			MILLIMETERS		
	MIN	NOM	MAX	MIN	NOM	MAX
A	.020	-	.024	0.50	-	0.60
A1	.000	-	.002	0.00	-	0.05
A2		(.006)			(0.152)	
b	.006	.008	.010	0.15	0.20	0.25
D	.114	.118	.122	2.90	3.00	3.10
D1	.061	.067	.071	1.55	1.70	1.80
E	.114	.118	.122	2.90	3.00	3.10
E1	.061	.067	.071	1.55	1.70	1.80
e		.016 BSC			0.40 BSC	
L	.012	.016	.020	0.30	0.40	0.50
N		20			20	
aaa		.003			0.08	
bbb		.004			0.10	

NOTES:

1. CONTROLLING DIMENSIONS ARE IN MILLIMETERS (ANGLES IN DEGREES).
2. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.
3. DAP IS 1.90 x 1.90mm.

Figure 16: Package Outline Drawing

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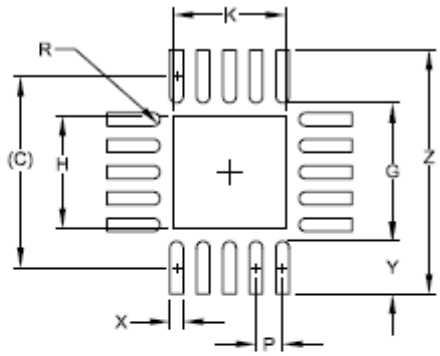
7.2 Land Pattern



DIMENSIONS		
DIM	INCHES	MILLIMETERS
C	(.114)	(2.90)
G	.083	2.10
H	.067	1.70
K	.067	1.70
P	.016	0.40
R	.004	0.10
X	.008	0.20
Y	.031	0.80
Z	.146	3.70

NOTES:

1. CONTROLLING DIMENSIONS ARE IN MILLIMETERS (ANGLES IN DEGREES).
2. THIS LAND PATTERN IS FOR REFERENCE PURPOSES ONLY. CONSULT YOUR MANUFACTURING GROUP TO ENSURE YOUR COMPANY'S MANUFACTURING GUIDELINES ARE MET.
3. THERMAL VIAS IN THE LAND PATTERN OF THE EXPOSED PAD SHALL BE CONNECTED TO A SYSTEM GROUND PLANE. FAILURE TO DO SO MAY COMPROMISE THE THERMAL AND/OR FUNCTIONAL PERFORMANCE OF THE DEVICE.

Figure 17: Package Land Pattern

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